

# Erratum to: Effects of Forming Processes on the Microstructure and Solderability of Sn-3.5Ag Eutectic Solder Ribbons as well as the Mechanical Properties of Solder Joints

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## **Erratum to: Journal of ELECTRONIC MATERIALS** **DOI: 10.1007/s11664-017-5672-9**

In the third paragraph of “Introduction” in the original article, the term  $\text{Ag}_3\text{Snm}$  should be  $\text{Ag}_3\text{Sn}$ .  
The original article has been updated.